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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10706985 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>CHA ET AL. |
|  | <b>Examiner</b><br><br>Bayat, Ali              | <b>Art Unit</b><br><br>2624                                      |

| SEARCHED |                                     |         |          |
|----------|-------------------------------------|---------|----------|
| Class    | Subclass                            | Date    | Examiner |
| 382      | 232,233,236,238,245,246,248,250,251 | 6/23/07 | A.B      |
| 348      | 395,403,405                         | 6/23/07 | A.B      |
| 358      | 426.01,426.12,426.16                | 6/23/07 | A.B      |

| SEARCH NOTES   |         |          |
|--|---------|----------|
| Search Notes   | Date    | Examiner |
| EAST ( US-PGPUB; USPTO; EPO;JPO;DERWENT; IMB-TDB), See text search history prin out. | 6/23/07 | A.B      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |